Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/688,294	CHEN ET AL.
Examiner	Art Unit
Pia F. Tibbits	2838

SEARCHED				
Class	Subclass	Date	Examiner	
320	106	2/26/2006	PT	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
320	106	2/26/2006	PT	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
east (interference search-att'd)	2/26/2006	PΤ